

<b>Notice of References Cited</b>	Application/Control No. 10/824,534		Applicant(s)/Patent Under Reexamination CHEN, CHUN-TING	
	Examiner Allen T. Cao		Art Unit 2627	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,712,424	03-2004	Swain, Daniel B.	296/180.1
*	B	US-7,073,183	07-2006	Hekizono, Kiyoshi	720/610
*	C	US-6,954,938	10-2005	Emberty et al.	720/632
*	D	US-5,485,330	01-1996	Hirose et al.	360/99.06
*	E	US-5,784,350	07-1998	Akiba et al.	720/606
*	F	US-6,930,727	08-2005	Uwagawa et al.	348/374
*	G	US-6,272,090	08-2001	Maeda, Nobunari	720/607
*	H	US-6,111,848	08-2000	Hui, John	369/30.41
*	I	US-2006/0161931	07-2006	Chen et al.	720/610
*	J	US-7,043,740	05-2006	Chen et al.	720/610
*	K	US-2005/0066342	03-2005	Tu, Chin-Fa	720/610
*	L	US-6,981,270	12-2005	Wu, Jen-Chen	720/610
*	M	US-2004/0261088	12-2004	HSU et al.	720/601

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.